

N-Channel MOSFET

General Description

The WSD220N06DN56 uses advanced SGT II technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 10V. This device is suitable for use as a Battery protection or in other Switching application.

The WSD220N06DN56 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

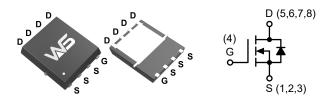
Product Summery

BV _{DSS}	R _{DS(ON)}	I _D
60V	1.0mΩ	220A

Applications

- Battery protection
- Uninterruptible Power Supply(UPS)

DFN5X6-8L Pin Configuration



Absolute Maximum Ratings (T_C=25°C, Unless Otherwise Noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current ^{1,6}	220	А
I _D @T _C =100°C	Continuous Drain Current 1,6	158	А
I _{DM}	Pulsed Drain Current ²	1340	А
E _{AS}	Single Pulse Avalanche Energy ³	580	mJ
I _{AS}	Avalanche Current	47	А
P _D @T _C =25°C	Power Dissipation ⁴	231	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient ¹		55	°C/W
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case ¹		0.65	°C/W



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Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	60			V	
R _{DS(ON)}	Static Drain-Source On-Resistance ⁴	V _{GS} =10V , I _D =20A		1.0	1.3	mΩ	
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250\mu A$	2.0	2.9	4.0	V	
	Drain Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =25°C			1.0		
I _{DSS}	Drain-Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =100°C			100	μA	
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V , V _{GS} =±20V			±100	nA	
g _{fs}	Forward Transconductance ⁴	V _{GS} =10V , I _D =20A		62		S	
Q_g	Total Gate Charge	V 20V V 40V		102		nC	
Q_{gs}	Gate-Source Charge	V _{DS} =30V , V _{GS} =10V , I _D =20A		24.6			
Q _{gd}	Gate-Drain Charge	- ID-20A		28.2			
T _{d(on)}	Turn-On Delay Time			15.6			
T _r	Rise Time	V _{DS} =30V , V _{GS} =10V ,		29		no	
T _{d(off)}	Turn-Off Delay Time	$R_G=3\Omega$, $I_D=20A$		63		ns	
T _f	Fall Time			51			
C _{iss}	Input Capacitance			5990			
C _{oss}	Output Capacitance	V_{DS} =30V , V_{GS} =0V , f = 1.0MHz		2257	pF		
C _{rss}	Reverse Transfer Capacitance			86			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I _S	Continuous Source Current	T _C =25°C			378	Α
V _{SD}	Diode Forward Voltage ⁴	V _{GS} =0V , I _S =20A			1.2	V
t _{rr}	Reverse Recovery Time	1 -204 d1/dt-1004/up		80		ns
Q _{rr}	Reverse Recovery Charge	- I _F =20A , dI/dt=100A/μs		114		μC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width .The $\,E_{AS}\,$ data shows Max. rating .
- 3. The power dissipation is limited by 175°C junction temperature
- 4. E_{AS} condition: T_J =25°C, V_{DD} =48V, V_G =10V, R_G =25 Ω , L=0.1mH, I_{AS} = 55A
- 5. The data is theoretically the same as $\ensuremath{I_D}$ and $\ensuremath{I_{DM}}$, in real applications , should be limited by total power dissipation.



Typical Characteristics

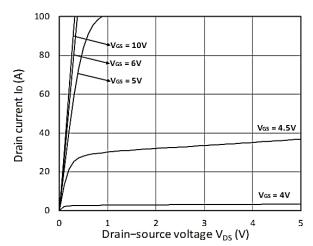


Figure 1. Output Characteristics

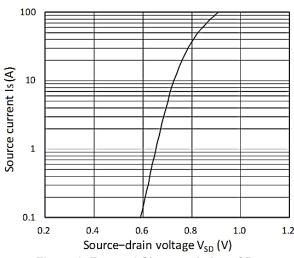


Figure 3. Forward Characteristics of Reverse

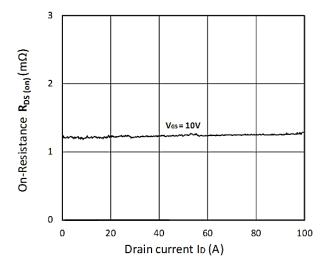


Figure 5. R DS(ON) vs. ID

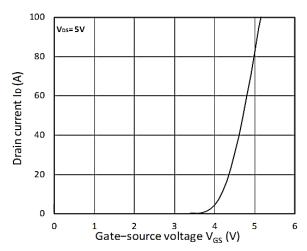


Figure 2. Transfer Characteristics

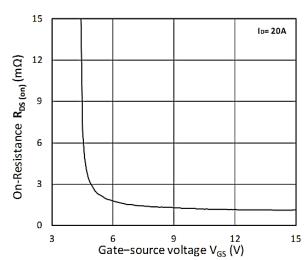


Figure 4. RDS(ON) vs. VGS

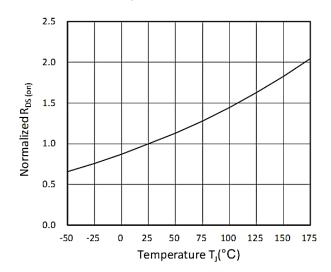


Figure 6. Normalized R DS(on) vs. Temperature



Typical Characteristics (Cont.)

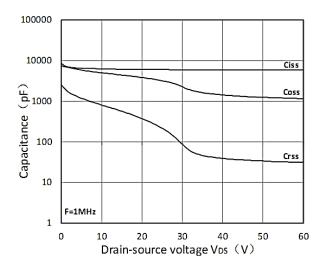


Figure 7. Capacitance Characteristics

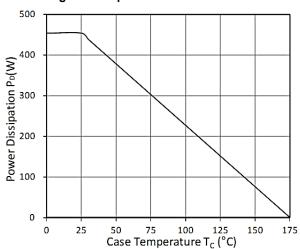


Figure 9. Power Dissipation

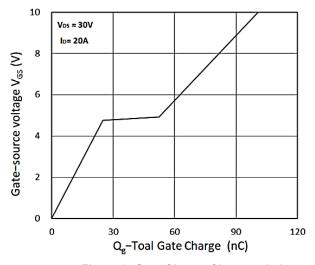


Figure 8. Gate Charge Characteristics

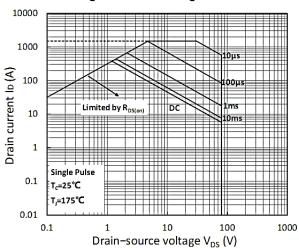


Figure 10. Safe Operating Area

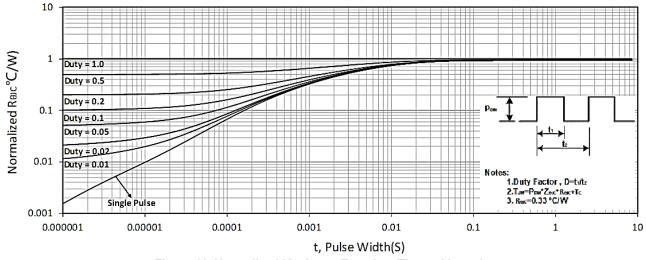
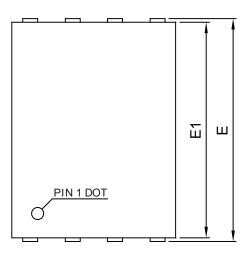


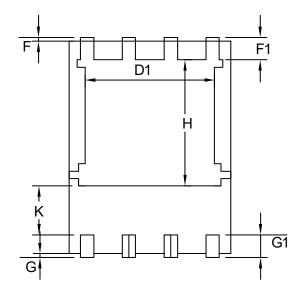
Figure 11. Normalized Maximum Transient Thermal Impedance

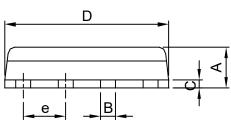


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Packaging information

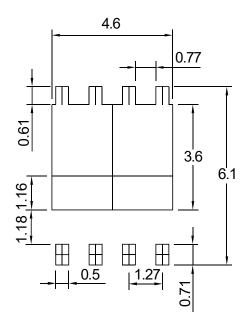






	DFN5X6-8L				
SYMBOL	MILLIM	ETERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	0.90	1.20	0.035	0.047	
В	0.30	0.51	0.012	0.020	
С	0.19	0.25	0.007	0.010	
D	4.80	5.30	0.189	0.209	
D1	4.00	4.40	0.157	0.173	
Е	5.90	6.20	0.232	0.244	
E1	5.50	5.80	0.217	0.228	
е	1.27	BSC	0.050	BSC	
F	0.05	0.30	0.002	0.012	
F1	0.35	0.75	0.014	0.030	
G	0.05	0.30	0.002	0.012	
G1	0.35	0.75	0.014	0.030	
Н	3.34	3.90	0.131	0.154	
K	0.762	-	0.033	-	

RECOMMENDED LAND PATTERN



UNIT: mm



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